

**Search Notes**

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Examiner

John P. Leubecker

Applicant(s)/Patent under  
Reexamination

KIM ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
Updated	Search	10/12/2005	JPL

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR